

## SMALL SIGNAL SCHOTTKY DIODE


**MINIMELF**  
 (Glass)

### DESCRIPTION

Metal to silicon junction diode primarily intended for UHF mixers and ultrafast switching applications.  
 Matched batches are available on request.

### ABSOLUTE MAXIMUM RATINGS (limiting values)

Symbol	Parameter		Value	Unit
$V_{RRM}$	Repetitive Peak Reverse Voltage		10	V
$I_F$	Forward Continuous Current	$T_i = 25^\circ\text{C}$	30	mA
$I_{FSM}$	Surge non Repetitive Forward Current	$t_p \leq 1\text{s}$	60	mA
$T_{stg}$ $T_j$	Storage and Junction Temperature Range		- 65 to +150 - 65 to +125	$^\circ\text{C}$ $^\circ\text{C}$
$T_L$	Maximum Temperature for Soldering during 15s		260	$^\circ\text{C}$

### THERMAL RESISTANCE

Symbol	Test Conditions	Value	Unit
$R_{th(j-l)}$	Junction-leads	400	$^\circ\text{C}/\text{W}$

### ELECTRICAL CHARACTERISTICS

#### STATIC CHARACTERISTICS

Symbol	Test Conditions		Min.	Typ.	Max.	Unit
$V_{BR}$	$T_{amb} = 25^\circ\text{C}$	$I_R = 10\mu\text{A}$	10			V
$V_F$ (1)	$T_{amb} = 25^\circ\text{C}$	$I_F = 1\text{mA}$			0.4	V
	$T_{amb} = 25^\circ\text{C}$	$I_F = 20\text{mA}$			1	
$I_R$ (1)	$T_{amb} = 25^\circ\text{C}$	$V_R = 5\text{V}$			0.1	$\mu\text{A}$

#### DYNAMIC CHARACTERISTICS

Symbol	Test Conditions			Min.	Typ.	Max.	Unit
C	$T_{amb} = 25^\circ\text{C}$	$V_R = 0\text{V}$	$f = 1\text{GHz}$			1.2	pF
$\tau$	$T_{amb} = 25^\circ\text{C}$	$I_F = 20\text{mA}$	Krakauer Method			100	ps
F (2)	$T_{amb} = 25^\circ\text{C}$	$f = 1\text{GHz}$			6		dB

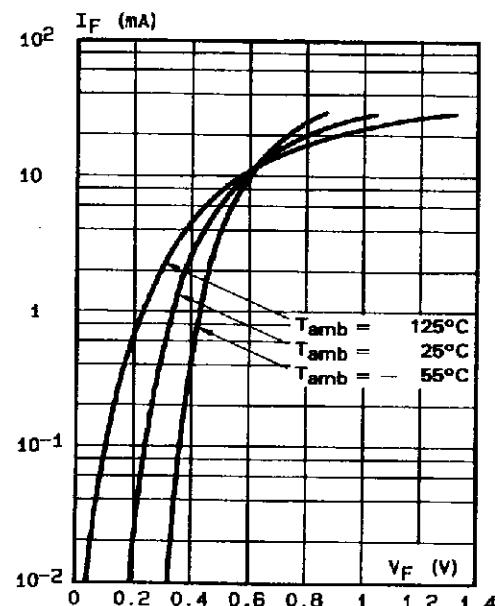
(1) Pulse test:  $t_p \leq 300\mu\text{s}$   $\delta < 2\%$ .

(2) Noise figure test :

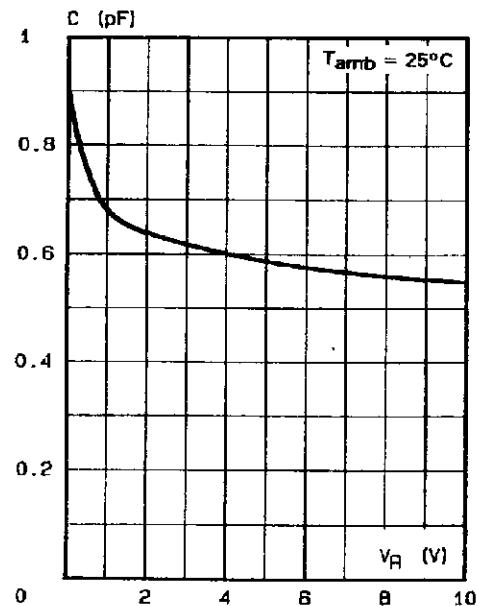
- diode is inserted in a tuned stripline circuit
- local oscillator frequency 1GHz
- local oscillator power 1mW
- intermediate frequency amplifier, tuned on 30MHz, has a noise figure 1.5dB

Matched batches available on request. Test conditions (forward voltage and/or capacitance) according to customer specification.

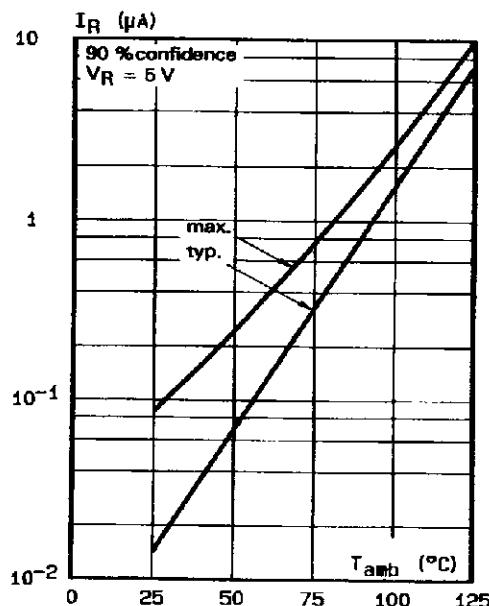
**Figure 1. Forward current versus forward voltage at low level (typical values).**



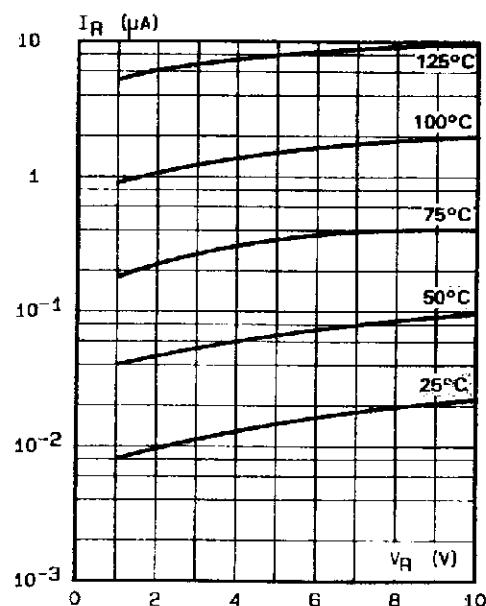
**Figure 2. Capacitance C versus reverse applied voltage  $V_R$  (typical values).**



**Figure 3. Reverse current versus ambient temperature.**

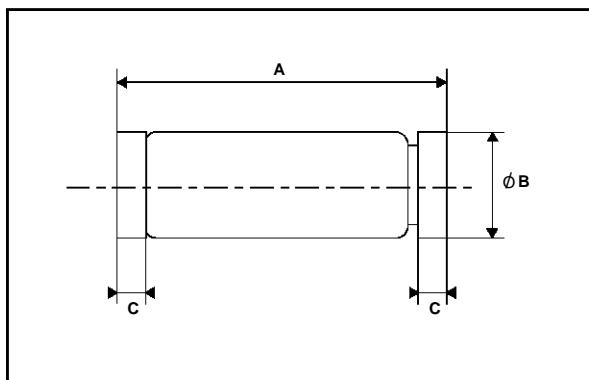


**Figure 4. Reverse current versus continuous reverse voltage (typical values).**

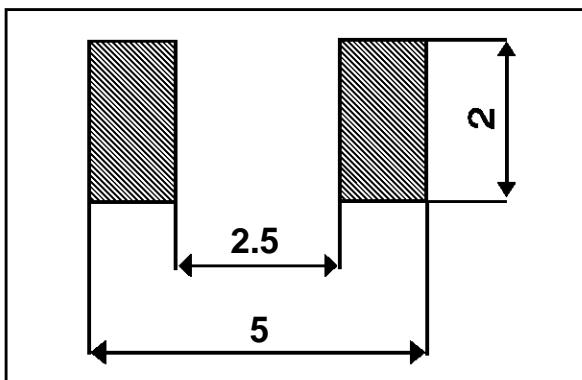


## PACKAGE MECHANICAL DATA

MINIMELF Glass



## FOOT PRINT DIMENSIONS (Millimeter)



REF.	DIMENSIONS			
	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	3.3	3.6	0.130	0.142
B	1.59	1.62	0.063	0.064
C	0.4	0.5	0.016	0.020

Marking: ring at cathode end.

Weight: 0.05g

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